

Notice of References Cited

Application/Control No.

10/574,583

Applicant(s)/Patent Under

Reexamination

MATSUMOTO ET AL.

Examiner

JAIME M. GREENE

Art Unit

1634

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0127904	06-2006	Segawa et al.	435/006
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	V	Chou, et al. Biophys J. 2002 October; 83(4): 2170-2179.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
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